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FDB86102LZ N-Channel PowerTrench[®] MOSFET 100 V, 30 A, 24 m Ω

Features

- Max $r_{DS(on)} = 24 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 8.3 \text{ A}$
- Max $r_{DS(on)}$ = 35 m Ω at V_{GS} = 4.5 V, I_D = 6.8 A
- HBM ESD protection level > 6 kV typical (Note 4)
- Very low Qg and Qgd compared to competing trench technologies
- Fast switching speed
- 100% UIL Tested
- RoHS Compliant



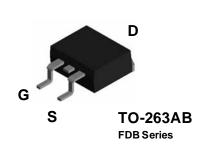
May 2011

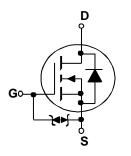
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize the on-state resistance and switching loss. G-S zener has been added to enhance ESD voltage level.

Applications

- DC-DC conversion
- Inverter
- Synchronous Rectifier





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			100	V
V _{GS}	Gate to Source Voltage		±20	V	
	Drain Current -Continuous(Package limited) Tc = 25 °C		°C	30	
	-Continuous (Silicon limited) Tc = 25 °C		°C	40	
D	-Continuous	TA = 25	°C (Note 1a)	8.3	Α
	-Pulsed			50	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	121	mJ
P _D	Power Dissipation	T _A = 25 °C	(Note 1a)	3.1	14/
	Power Dissipation	T _A = 25 °C	(Note 1b)	2	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Note 1)	1.9	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	40	°C/vv

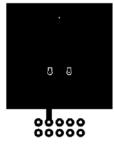
Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB86102LZ	FDB86102LZ	TO-263AB	330mm	24 mm	800 units

Electri Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		69		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA
On Char	acteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	1.0	1.5	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		-6		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 8.3 A		18	24	
		V _{GS} = 4.5 V, I _D = 6.8 A		23	35	mΩ
()		V _{GS} = 10 V, I _D = 8.3 A,T _J = 125 °C		31	42	
9 _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, \ \text{I}_{D} = 8.3 \text{ A}$		29		S
Dvnamic	Characteristics					
C _{iss}	Input Capacitance			959	1275	pF
C _{oss}	Output Capacitance	─ V _{DS} = 50 V, V _{GS} = 0 V, f = 1MHz		181	240	pF
C _{rss}	Reverse Transfer Capacitance	1 = 1101112		9	13	pF
R _g	Gate Resistance			0.4		Ω
Switchin	g Characteristics					
t _{d(on)}	Turn-On Delay Time			6.6	13	ns
ului i		V _{DD} = 50 V, I _D = 8.3 A,		2.1	10	ns
	Rise Time	$v_{DD} = 30 v, i_{D} = 0.3 \Lambda,$				
t _r	Rise Time Turn-Off Delay Time	$V_{\rm DD} = 30$ V, $V_{\rm D} = 0.3$ A, $V_{\rm GS} = 10$ V, $R_{\rm GEN} = 6$ Ω		18.2	33	ns
t _r		$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		18.2 2.3	33 10	ns ns
t _r t _{d(off)} t _f	Turn-Off Delay Time	$V_{GS} = 0 V to 10 V$		-		-
t _r t _{d(off)} t _f Q _{g(TOT)}	Turn-Off Delay Time Fall Time	$V_{GS} = 10 \text{ V}, \overline{\text{R}}_{\text{GEN}} = 6 \Omega$		2.3	10	ns
t_r $t_{d(off)}$ t_f $Q_{g(TOT)}$ $Q_{g(TOT)}$	Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = 10 \text{ V}, $		2.3 15.2	10 21	ns nC
t _r t _{d(off)} t _f Q _{g(TOT)} Q _{g(TOT)} Q _{gs}	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge	$V_{GS} = 10 \text{ V}, \ \bar{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 50 \text{ V},$		2.3 15.2 7.6	10 21	ns nC nC
$\begin{array}{c} t_{d}(off) \\ \hline t_{d}(off) \\ \hline t_{f} \\ \hline Q_{g(TOT)} \\ Q_{g(TOT)} \\ \hline Q_{gs} \\ \hline Q_{gd} \\ \end{array}$	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge	$V_{GS} = 10 \text{ V}, \ \bar{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 50 \text{ V},$		2.3 15.2 7.6 2.4	10 21	ns nC nC nC
$\begin{array}{c} t_r \\ t_{d(off)} \\ t_{f} \\ Q_{g(TOT)} \\ Q_{g(TOT)} \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge Durce Diode Characteristics	$V_{GS} = 10 \text{ V}, $		2.3 15.2 7.6 2.4	10 21	ns nC nC nC
$\begin{array}{c} t_{r} \\ t_{d(off)} \\ t_{f} \\ Q_{g(TOT)} \\ Q_{g(TOT)} \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate ChargeGate to Source ChargeGate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}, $		2.3 15.2 7.6 2.4 2.5	10 21 11	ns nC nC nC
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NOTES:

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 40 °C/W when mounted on a 1 in² pad of 2 oz copper

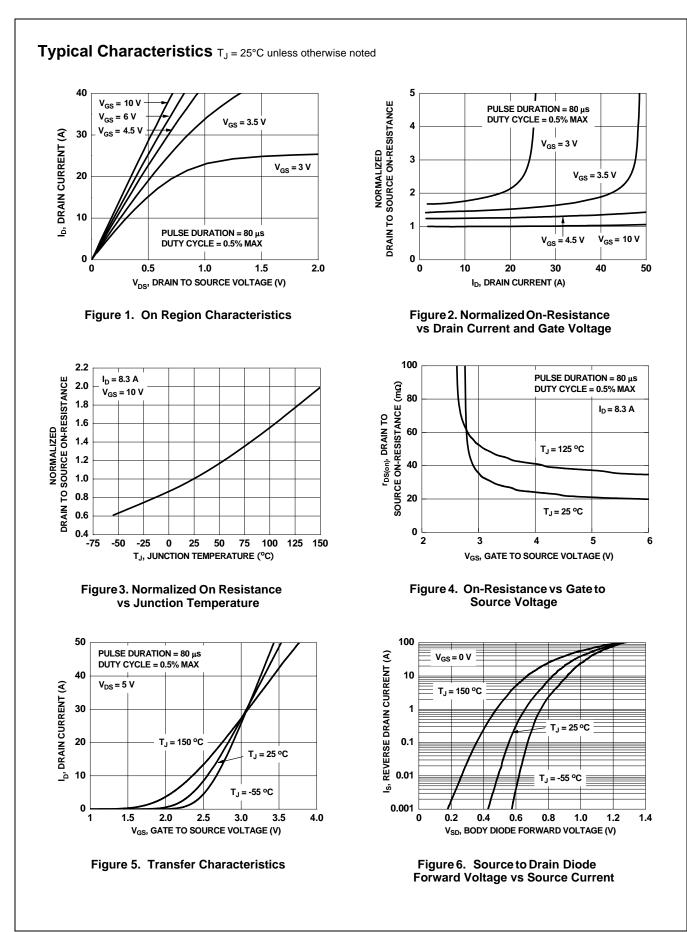


b) 62.5 °C/W when mounted on a minimum pad of 2 oz copper

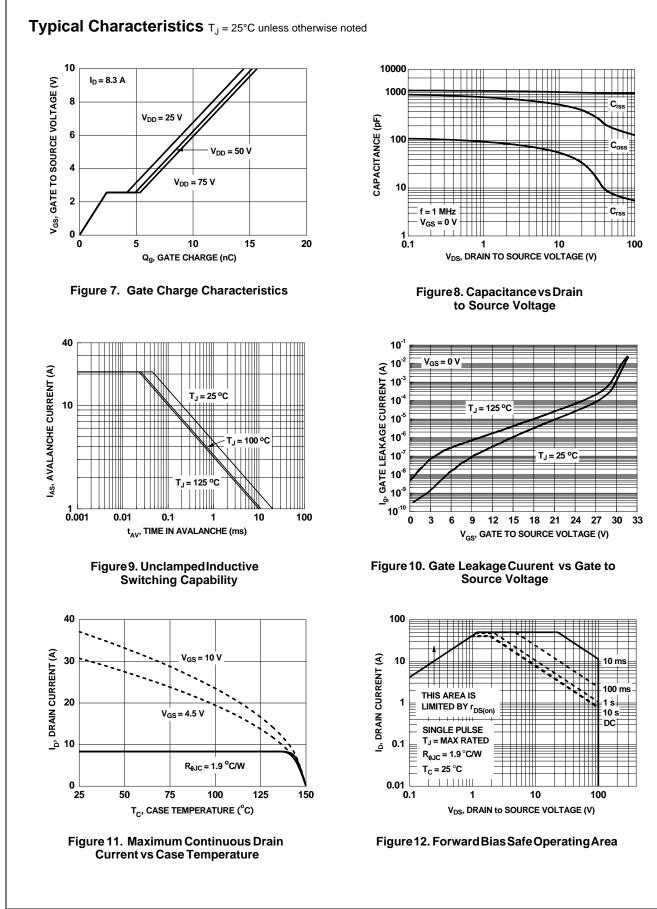


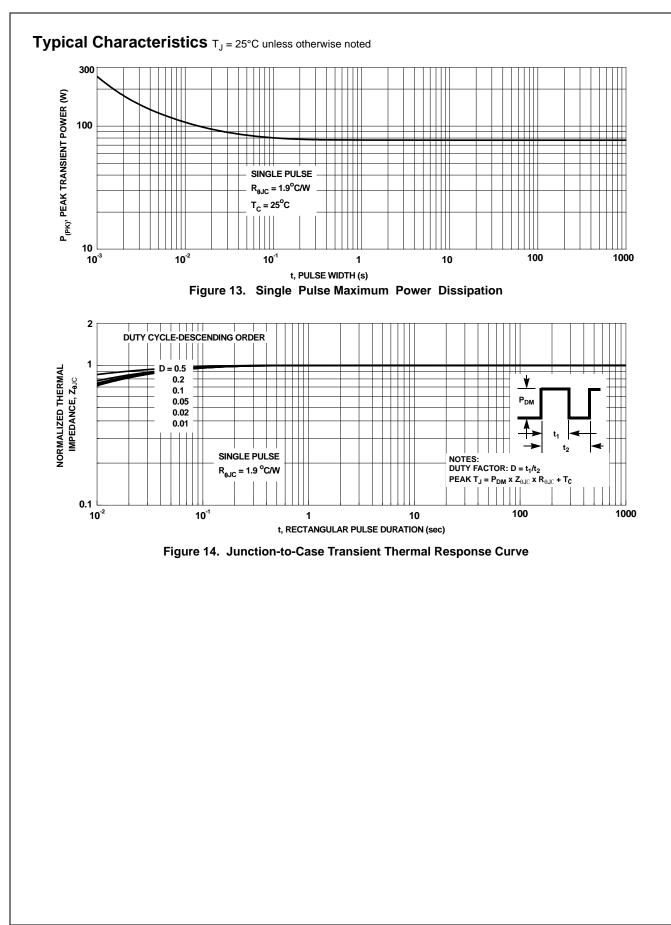
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Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.
 Starting T_J = 25 °C, L = 3 mH, I_{AS} = 9 A, V_{DD} = 100 V, V_{GS} = 10 V.
 The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.











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